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Ionization rate coefficients for the elements hydrogen through zinc*

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ABSTRACT

Aims. The interpretation of astrophysical spectra depends directly on a knowledge of the ionization state of the emitting plasma. This is determined, in part, from collisional ionization rate coefficients. The most recent assessments of these were performed by Arnaud & Rothenflug (1985, A&AS, 60, 425) and Arnaud & Raymond (1992, ApJ, 398, 394). Since their work, new laboratory measurements of ionization cross sections have become available as well as the Flexible Atomic Code (FAC) which enables theoretical calculations of these rates. Our goal is to provide a complete set of ionization rate coefficients for the elements hydrogen through zinc.

Methods. A scaling law, which assists the analysis of ionization cross sections and rate coefficients, has been developed following the approach of Burgess & Tully (1992, A&A, 254, 436). Essentially all available measured cross sections along each isoelectronic sequence have been examined and compared to cross sections calculated with the Flexible Atomic Code (FAC) and with other calculations. Two approaches has been taken to provide a complete set of ionization cross sections. In the first, fits to scaled measured ionization cross sections, particularly for neutral and singly ionized species, are performed. In the second, fits to scaled calculated direct ionization and excitation-autoionization cross sections are performed to provide the remainder of the set. The fits to the cross sections are then integrated over a Maxwellian velocity distribution to derive ionization rate coefficients.

Results. A complete set of ground level ionization cross sections and rate coefficients has been developed through the combination of these two approaches. A tabulation of parameter fits to ground level ionization rate coefficients for all atoms and ions of the elements of H through Zn is provided.

Key words. atomic data – atomic processes – plasmas

1. Introduction

The interpretation of astrophysical spectra depends directly on a knowledge of the ionization state of the observed plasma. In a collisionally dominated plasma, such as the solar corona, the ionization state is determined by a balance of the electron collisional ionization rates and the radiative and dielectronic recombination rates. Whether the plasma is considered to be in a steady or transient state, it is necessary to have an accurate knowledge of these rates. This paper describes a new complete set of ionization rate coefficients for all ions of all elements from hydrogen through zinc based on the most recently available laboratory measurements and theoretical calculations.

Prior to this work, the most recent analysis of ionization rates was performed by Arnaud & Rothenflug (1985) and by Arnaud & Raymond (1992) for iron. Since that time, a number of new laboratory measurements have been performed and reported and the Flexible Atomic Code (FAC) has been developed by Gu (2002) to enable calculations of ionization cross sections. In addition, the use of scaling laws, such as those developed by Burgess & Tully (1992) for collisional excitation, have proven useful. In many important respects, this analysis follows the earlier analyses of Arnaud & Rothenflug (1985) and Arnaud & Raymond (1992) with a strong reliance on both observational and theoretical results.

The result of this analysis is a set of spline fits to scaled temperatures and scaled ionization rate coefficients that are available electronically. Further, the cross sections and rate coefficients will be available through the CHIANTI atomic database for astrophysical spectroscopy Dere et al. (1997), Landi et al. (2006).

2. Approach

Ionization caused by the collision of electrons with neutral and ionized species occurs primarily through two mechanisms. The first is direct ionization (DI) where a bound electron is converted to a free electron in the collision. The second process is usually referred to as "excitation-autoionization" (EA). Here, a bound electron is excited into an autoionizing state. At this point, there is a competition between a stabilizing radiative transition and an autoionizing transition. The relative contributions of the two processes can vary considerably with isoelectronic sequence. For the hydrogen through neon isoelectronic sequences, direct ionization dominates. For more complex ions, EA is often the dominant ionization process.

2.1. Empirical scaling laws for ionization

Lotz (1967a) developed the "classical" ionization scaling, where the scaled cross section is given by cross section multiplied by the square of the ionization potential and the scaled energy is given by incident electron energy divided by the ionization potential. The importance of this scaling is that classically

^{*} Full Table 29 is only available in electronic form at the CDS via anonymous ftp to cdsarc.u-strasbg.fr (130.79.128.5) or via http://cdsweb.u-strasbg.fr/cgi-bin/qcat?J/A+A/466/771

scaled ionization cross section plotted *versus* scaled energy varies slowly along an isoelectronic sequence, particularly at high values of the nuclear charge Z.

Bethe (1930) showed that at high energy, the ionization cross section scales as $\sigma \sim C \log u/u$ where σ is the direct ionization cross section, u is the scaled energy E/I, E is the energy of the incident electron and I is the ionization potential. The constant C is the Bethe coefficient and is give by Younger (1981c)

$$C = \frac{I}{\pi \alpha} \int \frac{\sigma_{\rm PI}}{\epsilon} \, \mathrm{d}\epsilon \tag{1}$$

where α is the fine structure constant, $\sigma_{\rm PI}$ is the photoionization cross section and ϵ is the photon energy. The photoionization cross sections of Verner & Yakovlev (1995) have been used to calculation the Bethe coefficient for all of the ionization cross sections reported here. Further, the collision strength, a component of the EA rate, also approaches a high energy limit $\Omega \sim (4gf/\Delta E) \log u$ where gf is the weighted oscillator strength and ΔE the excitation energy Burgess & Tully (1992).

The CHIANTI database has made extensive use of the scaling laws that Burgess & Tully (1992) developed for collisional excitation. A similar scaling law for ionization cross sections has been developed here. It is based on a combination of the classical cross section scaling of Lotz (1967a), the Bethe (1930) limit for direct ionization and the Burgess & Tully (1992) scaling for allowed transitions. The scaling involves a scaled energy U,

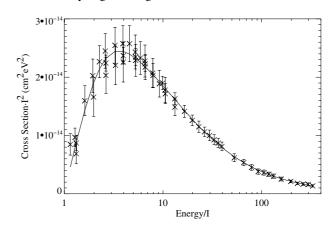
$$U = 1 - \frac{\log f}{\log(u - 1 + f)} \tag{2}$$

and a scaled cross section Σ in a manner similar to Burgess & Tully (1992),

$$\Sigma = \frac{u \,\sigma \,I^2}{\log(u) + 1}.\tag{3}$$

Here f is an adjustable parameter. This type of scaling will be referred to as BT scaling and has several advantages. The energy range from threshold to infinity is mapped onto a finite scale from zero to unity. The extended high energy range is highly compressed while the energy range just above threshold is expanded. The scaled cross section Σ approaches a known constant at high energy and for fitting cross sections, the threshold value for Σ for U=0 (u=1) can be set to zero. As with classically scaled cross sections, the BT cross section scaling approaches a fixed function as one proceeds along an isoelectronic sequence, at least in the case of direct ionization.

Figure 1 shows an example of this approach as applied to measurements of Li II. This ion contains only 2 electrons in the 1s shell so that the direct cross section should not show any structure resulting from ionization from different shells. The measurements extend to nearly 400 times the threshold value. The cross sections at the highest energies are from the measurements of Peart & Dolder (1968) who sought to verify the high energy scaling. The other measurements are from Lineberger et al. (1966), Peart et al. (1969b), and Wareing (1967). The fit to the experimental data is shown for classical scaling (top) and for BT scaling (bottom). It can be seen that the ionization cross section does approach a constant value at BT scaled energies of about 0.8 but this that value is about 40% higher than the high-energy Bethe limit. In fact, the measured cross sections have often been found to approach a high-energy limit that is a factor of 1.4 to 2.0 higher than the Bethe limit. Nevertheless, the Bethe limit has been used for all of the ionization cross section fits.



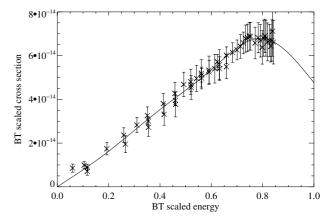


Fig. 1. *Top*: classically scaled ionization cross section for Li II. *Bottom*: BT scaled cross section versus scaled energy and the fit to the data.

One of the techniques used here to obtain ionization cross sections over the entire range of energies is to derive a spine fit to the BT scaled measurements. As this procedure results in a smoothly varying curve, it is only used for cases where there is little apparent structure in the measured cross sections. Typically this is the case for neutrals and singly ionized species.

2.2. Calculation of ionization cross sections

FAC has been used to calculate the DI cross sections from inner and outer shells of the various ions as explained later in the text. The ionization potentials are taken from the CHIANTI database, which in turn, are largely based on values from the NIST database Ralchenko et al. (2006). Cross sections for excitation autoionization have also been calculated with FAC. This involved solving the atomic structure, calculating collision strengths into auto-ionizing levels and determining the branching ratio for ionization. All of the rates have been summed into a reduced set and fit with a Burgess & Tully (1992) scaling, including a value for the high energy limit. The FAC distorted wave calculations tend to be most accurate for doubly ionized species and higher. The use of scaling law fits to the cross sections of neutrals and singly-ionized ions is often the most accurate approach.

2.3. Error estimates

Estimates of the errors in the cross sections are provided, as in Table 1. The column labeled *Experimental error* lists the total error in the individual experimental measurements. The column

Table 1. Ionization cross section measurements for the hydrogen iso-electronic sequence.

Ion	Data source	Experimental error	Final error
HI	Shah et al. (1987)	7%	7%
Не п	Achenbach et al. (1984)	10%	15%
	Defrance et al. (1981a)	_	
	Dolder et al. (1961)	25%	
	Peart et al. (1969b)	12%	
Li III	Tinschert et al. (1989a)	10%	10%
B V	Aichele et al. (1998)	10%	10%
CVI	Aichele et al. (1998)	10%	10%
N VII	Aichele et al. (1998)	10%	10%
O VIII	Aichele et al. (1998)	10%	10%
Fe xxvi	O'Rourke et al. (2001)	15%	15%

labeled *Final error* lists an estimate of error in the final cross section as compared to the experimental measurements. For example, if the the measurements are reproduced by the adopted cross sections to within the experimental error, then the experimental error is listed. If the adopted cross sections show deviations from the experimental measurements beyond the experimental errors, then an estimate of the typical deviation is listed.

3. Ionization cross sections

3.1. The hydrogen isoelectronic sequence

Aside from H I, the available cross section measurements for the hydrogen isoelectronic sequence are listed in Table 1. For H I, the cross sections of Shah et al. (1987) have been selected as an accurate, representative set. FAC has been used to calculate the DI cross sections. In addition, there are the relativistic distorted wave cross sections of Fontes et al. (1999) who suggest that their parametric fits should be accurate for $Z \ge 4$ (Be IV).

For H_I ionization cross section measurements cover more than 2 orders of magnitude in the incident electron energy. The BT scaled values are well fit and appear to approach the predicted high energy Bethe limit. For He II measurements are reported by Peart et al. (1969b), Dolder et al. (1961), Defrance et al. (1981a), and Achenbach et al. (1984). These values are all in agreement to within their quoted errors. The measurements of Peart et al. (1969b) extend to the highest energies and approach approach a value roughly 1.6 higher than the Bethe limit.

For the ions Li III and B v, neither the FAC nor the Fontes et al. (1999) cross sections provide optimal fits to the data but the BT scaled cross section measurements are well described by 6 point spline fits.

For C VI, N VII and O VIII, the measurements are well described by the Fontes et al. (1999) cross sections. The C VI cross sections are shown in Fig. 2. The Fontes et al. (1999) cross sections are also in fairly good agreement with the measurements of O'Rourke et al. (2001), being about 15% below the measured values at low energies but in good agreement above about 2*I*.

To summarize, the final compilation of ionization cross sections uses the fits to the BT scaled measurements for the ions H I, He II, Li III and B ν . For Be I ν the fits for B ν are included with the appropriate ionization potential. For all other ions, the Fontes et al. (1999) cross sections are included.

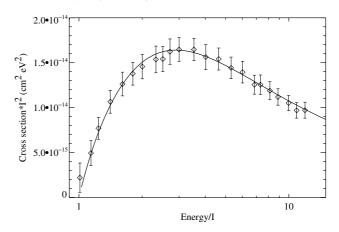


Fig. 2. Ionization cross sections for C VI. Diamonds – measurements of Aichele et al. (1998), solid line – calculations of Fontes et al. (1999).

3.2. The helium isoelectronic sequence

The available cross section measurements for the helium isoelectronic sequence are listed in Table 2. FAC has been used to calculate the DI cross sections. Fontes et al. (1999) has calculated relativistic distorted wave cross sections and provided parametric fits which are said to be accurate for $Z \ge 5$. At energies near 10*I*, they are generally higher that the FAC calculations since in the relativistic limit they approach a constant value rather than the classical non-relativistic Bethe limit.

For the ions He I and Li II, a distorted wave calculation can not be expected to accurately reproduce the measured cross sections and 6 point splines fit to the BT scaled measurements have been used. For BIV, the FAC cross sections are about 12% higher than the measurements at the peak of the cross section and the Fontes et al. (1999) cross sections do not accurately reproduce the measurements near threshold. Consequently, the BT scaled measurements were fit by a 6 point spline fit to provide greater accuracy. The FAC cross sections for CV reproduce the measurements of Crandall et al. (1979a) and Donets & Ovsyannikov (1981) quite well while those of Bannister & Havener (1996) show considerable cross section well below the threshold and are not considered further. The cross sections of Fontes et al. (1999) do not provide as good a fit. The FAC and measured cross sections for CV are show in Fig. 3 The measurements for N VI are not in good agreement with the other measurements in the sequence. The measurements for Ne IX are reproduced by both the FAC cross sections and those of Fontes et al. (1999) to well within the experimental

For the final compilation of ionization cross sections, the fits to the BT scaled measurements for He I, Li II and B IV were used. For Be III, the fits for B IV were used with the appropriate ionization potential. For C V through F VIII the FAC cross sections are used. For ions with higher Z, the cross sections of Fontes et al. (1999) are included.

3.3. The lithium isoelectronic sequence

Measurements of ionization cross sections for ions in the lithium sequence are shown in Table 3. The experimental cross sections show a noticeable EA contribution for the more highly ionized species. DI and EA cross sections were calculated with FAC. The DI cross sections include ionization from the 1s and 2s levels. The EA cross sections include excitations to the 1s2/12l' and 1s2/13l' levels. Chen et al. (1996) has calculated EA ionization

=				
			Experimental	Final
Ion	Data source	Unused data source	error	error
Не і	Stephan et al. (1980)		8%	10%
	Montague et al. (1984b)		4%	
	Shah et al. (1988)		6%	
Li II	Lineberger et al. (1966)		12%	20%
	Peart et al. (1969b)		11%	
	Wareing (1967)		15%	
BIV	Crandall et al. (1979a)		4%	10%
CV	Crandall et al. (1979a)	Bannister & Havener (1996)	7%	10%
	Donets & Ovsyannikov (1981)		6%	
NVI	Crandall et al. (1979a)		14%	30%
Ne ix	Donets & Ovsyannikov (1981)		17%	20%

Table 2. Ionization cross section measurements for the helium isoelectronic sequence.

Duponchelle et al. (1997)

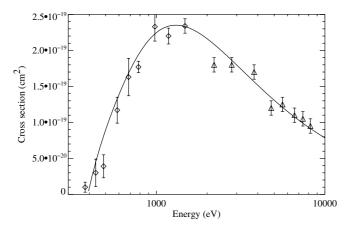


Fig. 3. FAC DI cross sections for Cv and the measurements of Crandall et al. (1979a) (diamonds) and Donets & Ovsyannikov (1981) (triangles, plotted with an arbitrary 10% experimental error).

rates for the lithium isoelectronic sequence and these agree well with the FAC calculations. The FAC cross sections are also in good agreement with the calculations of Reed & Chen (1996) for N v and F vII, Chen & Reed (1992) for Ar xVI and Fe xxIV and Badnell & Pindzola (1993) for Fe xXIV.

For Li I, Jalin et al. (1973) and McFarland & Kinney (1965) provide absolute measurements at high energies and Brink (1964) provides relative measurements at low energies. There is a difference of about a factor of 2.2 between the measurements of Jalin et al. (1973) and those of McFarland & Kinney (1965). The measurements of Jalin et al. (1973) show the smoothest extension to the high energy limit and so this set is considered the most accurate. The measurements of McFarland & Kinney (1965) were divided by a factor of 2.2 to provide a consistent set of measurements at high energy. The measurements of Brink (1964) were normalized to the high energy set and the BT scaled values of the 3 sets were fit with a 6-point spline fit. The error estimate refers to the high energy values.

For Be II and B III the measurements are well fit by a combination of a spline fit to the BT scaled DI cross sections and the addition of the FAC EA cross sections. In the case of C IV, the measurements of Teng et al. (2000) are about 22% higher than those of Crandall et al. (1979b) and Howald & Gregory (1984) but are in good agreement with the FAC DI and EA cross sections. The cross sections for N V, O VI and Ne VIII were well described by the FAC calculations although for Ne VIII the EA values appear to be somewhat underestimated. For the remaining

members of the lithium isoelectronic sequence, the FAC values have been used. Cross sections over narrow ranges of energy near the EA peak have been measured by Kenntner et al. (1995) for Si XII and Cl xv. The estimated error in these measurements is 20% but the FAC cross sections are about a factor of 1.3 higher than the Kenntner et al. (1995) measurements. The FAC cross sections also agree with the measurements of Wong et al. (1993) for a single energy near the peak of the direct ionization cross section for the ions of Ti xx, V xxI, Cr xxIII and Mn xxIII and Fe xxIV. The FAC and experimental cross sections for N v are shown in Fig. 4.

11%

To summarize, the final compilation includes spline fits to the BT scaled measurements of Li I, spline fits to the DI cross sections plus the FAC EA cross sections for Be II and B III, and the FAC DI plus EA cross sections for all other ions.

3.4. The beryllium isoelectronic sequence

The measured cross sections for ions in the beryllium isoelectronic sequence are listed in Table 4. DI and EA ionization cross sections for the beryllium isoelectronic sequence have been calculated with FAC. The DI values include ionization from the 1s and 2s shells. The EA rates consider excitation to the 1s2 l^3 and 1s2 l^2 3l' levels with the appropriate branching ratios. The FAC cross sections agree with the DI calculations of Younger (1981c) at the 10% level. For Ne VII, the FAC values lie midway between the DI+EA cross sections of Chen et al. (1998) and Laghas et al. (1999). The FAC values also agree to with 10% with DI+EA values of Badnell & Pindzola (1993) for Fe xxIII. From an inspection of Fig. 4 of Loch et al. (2003), the FAC cross sections also appear to be in good agreement with their calculations for O v.

The BT scaled measurements for BeI and BII are well reproduced by a spline fit. It should be noted that Tawara (2002) provides cross sections for ionization of all neutrals considered in this study. However, the author provides no citation of where the values come from nor any estimates of the errors. These values are only used if no others seem to be available. Laboratory measurements are also available for CIII, NIV and OV but these are apparently compromised by the existence of significant populations of ions in metastable 1s²2s2p levels. This situation was previously noted by Arnaud & Rothenflug (1985). Since their analysis, measurements of the ionization cross sections for Ne VII have been reported by Duponchelle et al. (1997) and Bannister (1996) that appear to be free of contamination by metastable levels. These measurements are well reproduced by the calculations of Laghas et al. (1999). The

Table 3. Ionization cross section measurements for the lithium isoelectronic sequence.

			Experimental	Final
Ion	Data source	Unused data source	error	error
LiI	Brink (1964)		_	15%
	Jalin et al. (1973)		18%	
	McFarland & Kinney (1965)		10%	
BeII	Falk & Dunn (1983)		8%	5%
ВШ	Crandall et al. (1986)		7%	5%
CIV	Teng et al. (2000)	Crandall et al. (1979b) Howald & Gregory (1984)	14%	12%
Nv	Crandall et al. (1979b)		7%	15%
	Defrance et al. (1990)		≥7%	
O VI	Crandall et al. (1979b)		16%	10%
	Crandall et al. (1986)		7%	
	Defrance et al. (1990)		≥7%	
	Rinn et al. (1987)		8%	
Ne viii	Defrance et al. (1990)		≥8%	15%
	Aichele et al. (2000)		9%	
	Donets & Ovsyannikov (1981)		7%	
	Duponchelle et al. (1997)		6%	
	Riahi et al. (2001)		_	
Si XII	Kenntner et al. (1995)		20%	30%
Clxv	Kenntner et al. (1995)		20%	30%
Ti xx	Wong et al. (1993)		11%	11%
Vxxi	Wong et al. (1993)		10%	10%
Cr xxII	Wong et al. (1993)		9%	9%
Mn xxiii	Wong et al. (1993)		9%	9%
Fe xxiv	Wong et al. (1993)		9%	9%

Table 4. Ionization cross section measurements for the beryllium isoelectronic sequence.

			Experimental	Final
Ion	Data source	Unused data source	error	error
Beı	Tawara (2002)		=	
Вп	Falk et al. (1983)		7%	7%
CIII		Falk et al. (1983)		
		Woodruff et al. (1978)		
NIV		Falk et al. (1983)		
		Howald & Gregory (1984)		
Ov		Crandall et al. (1979a)		
		Falk et al. (1983)		
Ne vii	Bannister (1996)	(-/00/	9%	6%
	Duponchelle et al. (1997)		6%	

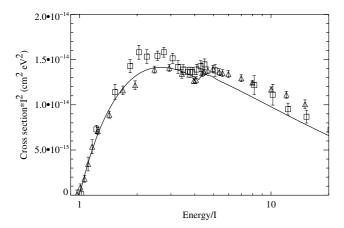


Fig. 4. FAC ionization cross sections of N v and experimental values. Triangles, Crandall et al. (1979a), squares, Defrance et al. (1990).

FAC cross sections and the measurements by Bannister (1996) and Duponchelle et al. (1997) for Ne VII are plotted together in

Fig. 5. It can be seen that the FAC cross sections reproduce the measurements quite well.

To summarize, the final compilation of ionization cross sections uses the spline fits to the BT scaled measurements for Be I and B II and the FAC cross sections for all of the remaining ions in the beryllium isoelectronic sequence.

3.5. The boron isoelectronic sequence

Table 5 shows the sources of cross section measurements for the boron isoelectronic sequence. There is no evidence for significant EA contributions to the measured cross sections. Consequently, FAC DI cross sections only, from the n=1 and n=2 shells, have been calculated for comparison with the measured values. The FAC values are in good agreement with the calculations of Chen et al. (1998) for Ne VI and Badnell & Pindzola (1993) for Fe 22. From an inspection of Fig. 3 of Loch et al. (2003), the FAC cross sections also appear to be in good agreement with their calculations for O IV.

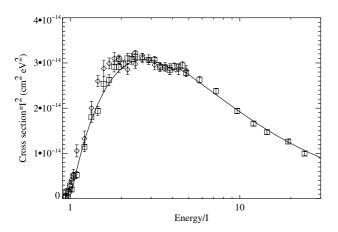


Fig. 5. Classically scaled ionization cross sections of Ne VII. Diamonds – Bannister (1996), squares – Duponchelle et al. (1997), solid line – FAC.

Table 5. Ionization cross section measurements for the boron isoelectronic sequence.

		Experimental	Final
Ion	Data source	error	error
Ві	Tawara (2002)	=	
CII	Yamada et al. (1989a)	10%	10%
N III	Bannister & Havener (1996)	8%	8%
	Mueller et al. (1983)	9%	
OIV	Crandall et al. (1979a)	8%	8%
Ne vi	Bannister (1996)	11%	12%
	Duponchelle et al. (1997)	6%	

For B I and C II, the measurements extend in energy to 1000 and 40 times threshold, respectively and fits to BT scaled measurements are satisfactory.

For the ions N III through Ne VI, the FAC cross sections underestimate the measured values from threshold to about twice threshold but are in good agreement at higher energies. For N III, two sets of measurements are available. The measurements of Mueller et al. (1985) extend from near threshold to about 5 times threshold while the measurements of Bannister & Havener (1996) extend from near threshold to about 20 times threshold. The two are not in strict agreement but the average of the two is in better agreement with other measurements along the isoelectronic sequence than either set of measurements on their own. In order to better reproduce the low energy cross sections, fits to the BT scaled measurements of both sets of measurements have been used.

The only set of measurements for O IV are those of Crandall et al. (1979a). In the case of Ne VI, the measurements of Bannister (1996) Duponchelle et al. (1997) are in good agreement at energies below about 1.7 times threshold. Near the peak cross section, the measurements of Duponchelle et al. (1997) are about 20% higher than those of Bannister (1996). As there is no apparent reason to value one over the other, a fit to the combined measurements has been used.

To summarize, the final compilation of ionization rates uses spline fits to the BT scaled measurements for BI, CII, NIII, OIV and Ne VI. For FV, a linear interpolations of the NIII and Ne VI fit parameters is used with the appropriate ionization potential. For the ions Na VII through Zn XXVI, the FAC DI cross sections are used.

3.6. The carbon isoelectronic sequence

Measurements of ionization cross sections for the carbon isoelectronic sequence are listed in Table 6. There is no evidence of EA contributions to the cross sections and FAC has been used to calculate the DI values for ionization from the n=1 and n=2 shells. Very good agreement with the Fe XXI DI cross sections of Younger (1982a) is found. From an inspection of Fig. 2 of Loch et al. (2003), the FAC cross sections appear to be in good agreement with their calculations for O III. The FAC values also appear to agree with the calculations for Al VIII of Aichele et al. (2001) as shown in their Fig. 6.

The BT scaled measurements of CI were fit with a spline. There is reasonably good agreement ($\pm 30\%$) between the FAC calculations and the measurements for NII, OIII and Ne V. However, fits to the BT scaled measurements provide a better reproduction of the measurements.

The measurements for Al VIII are described as problematical by the authors Aichele et al. (2001).

In summary, the final compilation of ionization cross sections used spline fits to the BT scaled measurements of CI, NII, OIII and Ne v. For FIV, the OIII and Ne v fits were linearly interpolated. For Al VIII and all other ions, the FAC DI cross sections are used.

3.7. The nitrogen isoelectronic sequence

Cross section measurements for the nitrogen isoelectronic sequence are listed in Table 7. There is no evidence for significant EA contributions and FAC has been used to calculate DI cross sections from the n=1 and n=2 shells. The FAC values are in good agreement with those of Chen et al. (1998) for Ne IV ($\pm 30\%$) and those of Younger (1982a) for Fe XX ($\pm 10\%$). For Ne IV, the measurements lie between between the two calculations. The FAC values also appear to agree with those of Aichele et al. (2001) for Al VII as shown in their Fig. 5.

Fits to the BT scaled cross sections for NI, OII, FIII and Ne IV were satisfactory. The FAC cross sections for Ne IV agree well with the measurements with a maximum deviation of about 12% near the peak. Cross section measurements for Al VII are provided by Aichele et al. (2001). These appear to be enhanced by the presence of metastables in the beam and do not agree well with the FAC DI cross sections. The measured cross sections for Si VIII and Ar XII are in good agreement with the FAC DI cross sections.

To summarize, for the final compilation, fits to the BT scaled cross sections are used for NI through NeIV and the FAC DI cross sections for the ions Na V through Zn XXIV.

3.8. The oxygen isoelectronic sequence

The available cross section measurements for the oxygen isoelectronic sequence are listed in Table 8. As with the boron, carbon and nitrogen isoelectronic sequences, there is no evidence for significant EA contributions. FAC has been used to calculate DI cross sections from the n=1 and n=2 shells. The FAC cross sections are in good agreement ($\pm 10\%$) with those of Chen et al. (1998) for Ne III and those of Younger (1982a) for Fe XIX. The FAC values also appear to agree with those of Aichele et al. (2001) for Al VI as shown in their Fig. 4.

For OI, the measurements of Brook et al. (1978) and Thompson et al. (1995) were used. The cross sections of Brook et al. (1978) below 30 eV indicated the presence of metastables so only their points at higher energies were included.

Table 6. Ionization cross section measurements for the carbon isoelectronic sequence.

			Experimental	Final
Ion	Data source	Unused data source	error	error
Cı	Brook et al. (1978)		5%	5%
NII	Yamada et al. (1989a)		10%	10%
O III	Falk et al. (1980)		10%	10%
Ne v	Bannister (1996)		9%	5%
	Duponchelle et al. (1997)		5%	
Al VIII		Aichele et al. (2001)		

Table 7. Ionization cross section measurements for the nitrogen isoelectronic sequence.

			Experimental	Final
Ion	Data source	Unused data source	error	error
ΝI	Brook et al. (1978)		4%	4%
OII	Yamada et al. (1989a)		10%	10%
FШ	Mueller et al. (1985)		9%	9%
Ne IV	Donets & Ovsyannikov (1981)		7%	8%
	Gregory et al. (1983)		8%	
Al VII		Aichele et al. (2001)		
Si VIII	Zeijlmans et al. (1993)	, ,	7%	10%
Ar XII	Zhang et al. (2002)		17%	17%

Table 8. Ionization cross section measurements for the oxygen isoelectronic sequence.

·			Experimental	Final
Ion	Data source	Unused data source	error	error
OI	Brook et al. (1978)		5%	5%
	Thompson et al. (1995)		5%	
FΠ	Yamada et al. (1989b)		10%	10%
Ne III	Bannister (1996)	Matsumoto et al. (1990)	9%	9%
Al VI		Aichele et al. (2001)		
Si VII	Zeijlmans et al. (1993)		7%	12%
Ar XI	Zhang et al. (2002)		9%	12%

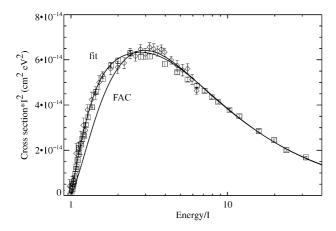


Fig. 6. Classically scaled ionization cross sections of Ne v. Diamonds – Bannister (1996), squares – Duponchelle et al. (1997), solid lines – FAC and the spline fit as noted.

Spline fits to the BT scaled cross sections for OI and FII provide a good reproduction of the measurements. For Ne III, the measurements of Bannister (1996) and Matsumoto et al. (1990) are in relatively good agreement, especially at energies less than roughly twice threshold and at energies above about 5 times threshold. At these energies, both are also in good agreement with the FAC DI cross sections. At the peak cross section,

the values of Bannister are about 15% lower than those of Matsumoto et al. (1990). The FAC DI cross sections are essentially accurate to within experimental uncertainties. However, the fits to Bannister (1996) for the Ne III cross sections have been used.

For more highly ionized species in the oxygen isoelectronic sequence, measurements by Aichele et al. (2001) for Al VI, measurements of Zeijlmans et al. (1993) for Si VII, and measurements of Zhang et al. (2002) for Ar XI are available. For Al VI, Aichele et al. (2001) suggests that the enhanced cross section at threshold is due to a fraction of the beam ions in a metastable $^1\mathrm{S}_0$ state. Our FAC DI rates appear to be consistent with the DW rates calculated by Aichele et al. (2001). Zeijlmans et al. (1993) suggest that the Si VII measurements also indicate the presence of metastable ions. The measured cross sections for Si VII are roughly 10% higher than the FAC cross sections. The Ar XI measurements are in good agreement with the FAC cross sections.

In summary, for the final compilation of ionization cross sections, spline fits to the BT scaled measurements are used for O I, F II and Ne III. Given the general level of agreement of the Ne III, Si VII and Ar XI measurements with the FAC DI cross sections, they are used for the ions Na IV through Zn XXIII.

3.9. The fluorine isoelectronic sequence

The available cross section measurements for the fluorine isoelectronic sequence are listed in Table 9. FAC has been used to

Table 9. Ionization cross section measurements for the fluorine isoelectronic sequence.

			Experimental	Final
Ion	Data source	Unused data source	error	error
FI	Hayes et al. (1987)		20%	20%
Ne II	Achenbach et al. (1984)	Müller et al. (1980)	10%	3%
	Diserens et al. (1984)	Yamada et al. (1989b)	3%	
	Man et al. (1987b)		3%	
Al v	Aichele et al. (2001)		8%	8%
Si VI	Thompson & Gregory (1994)		4%	4%
Ar X	Rachafi et al. (1987)		11%	16%

Table 10. Ionization cross section measurements for the neon isoelectronic sequence.

:			Experimental	Final
Ion	Data source	Unused data source	error	error
Neı	Almeida et al. (1995)		8%	8%
	Nagy et al. (1980)		7%	
	Stephan et al. (1980)		8%	
	Wetzel et al. (1987)		15%	
Na II	Hirayama et al. (1986)		13%	6%
	Hooper et al. (1966)		10%	
	Peart & Dolder (1968)		6%	
Mg III	Peart et al. (1969a)		8%	8%
Aliv		Aichele et al. (2001)		
Si v		Thompson & Gregory (1994)		
Arıx	Defrance et al. (1987)		10%	10%
	Zhang et al. (2002)		5%	

calculate DI cross sections from the n=1 and n=2 shells. Calculations by Aichele et al. (2001) for Al V suggest that the EA contributions to the cross section can be disregarded. The FAC values are in good agreement ($\pm 12\%$) with the calculations of Laghas et al. (1999) for Ar X and those of Younger (1982a) for Fe XVIII. The FAC values also appear to agree with those of Aichele et al. (2001) as shown in their Fig. 3.

For FI, the BT scaled measurements were well fit by a 6 point spline. For Ne II, the measurements of Achenbach et al. (1984), Diserens et al. (1984) and Man et al. (1987b) are in excellent agreement and extend to energies well above the threshold. The measurements of Yamada et al. (1989b) were in good agreement with these 3 sets of measurement but tended to diverge above 400 eV. Because the fit was well defined with the 3 sets of measurements just mentioned, the Yamada et al. (1989b) measurements were not included in the fits. The measurements of Müller et al. (1980) were at significant variance to all of the other sets and were not used. The BT scaled measurements of the 3 data sets are well fit with a 6 point spline.

The measurements of Al v Aichele et al. (2001) apparently correspond to excitation from the ground level alone and are in good agreement with the FAC and their CADW cross sections which include both direct and resonant ionization processes. The FAC cross sections for Si VI are in best agreement with the measured values of Thompson & Gregory (1994) at low energies and are about 23% higher at higher energies. For Ar X, the measured cross sections Rachafi et al. (1987) are in good agreement with the FAC cross sections.

For a compilation of the complete set of cross sections for the fluorine isoelectronic sequence, fits to the measured rates for F I, Ne II, Al V and Si VI are used. For all other members of the sequence, the FAC DI rates are used.

3.10. The neon isoelectronic sequence

The available cross section measurements for the neon isoelectronic sequence are listed in Table 10. The FAC DI cross sections consider ionization from the n=2 shell only and are in good ($\pm 10\%$) agreement with the calculations of Younger (1981a) for Al IV, Ar IX and Fe XVII.

There are 4 sets of ionization cross sections measurements for Ne I. The measurements of Stephan et al. (1980) and Wetzel et al. (1987) are for energies less than 10I and agree with each other. The measurements of Almeida et al. (1995) and Nagy et al. (1980) are for energies above 6I and 20I respectively and agree with each other as well. In the overlap region between 6 and 10I there is a disagreement of about 13% which is outside the quoted errors. For Ne I a 6 point spline fit to all 4 sets of the BT scaled measurements is used.

For NaII, there are 3 sets of measurements which are in reasonable agreement except that the values of Hirayama et al. (1986) at energies above about 10 I do not tend toward the high energy limit as well as those of Peart & Dolder (1968). Consequently, all of the data, except for the high energy points of Hirayama et al. (1986) has been used to arrive at a composite fit. The BT scaled measurements of Mg III byPeart et al. (1969a) are well described with a 6-point spline. Aichele et al. (2001) have analyzed their measurements for Al IV and suggest that the beam contained about about 20% of the ions in an excited state. When this is taken into account, the measurements seem to be consistent with the FAC direct ionization cross sections. Similarly, Thompson & Gregory (1994) found that their measured cross sections for Si V were affected by the presence of impurity metastable states. The two sets of Ar IX measurements were well fit by the FAC DI cross sections.

In summary, the fits to the BT scaled measurement for the Ne I, Na II and Mg III and the FAC DI cross sections for Al IV through Zn XXI are included in the final compilation.

Experimental Final Ion Data source Unused data source error error Naı McFarland & Kinney (1965) Brink (1964) 8% 8% Zapesochnyi & Aleksakhin (1969) 15% Mg II Becker et al. (2004) Crandall et al. (1982) 10% 10% Martin et al. (1968) Müller et al. (1990) 11% Peart et al. (1991b) 9% Al III Thomason & Peart (1998) Crandall et al. (1982) 8% 10% SiIV Crandall et al. (1982) 12% 12% Ar VIII Rachafi et al. (1991) Zhang et al. (1992) 40% 40% Ti XII Gregory et al. (1990) 7% 8% Cr xiv Gregory et al. (1990) 10% 25% Fe xvi Gregory et al. (1987) 14% 20% Linkemann et al. (1995) 20%

Table 11. Ionization cross section measurements for the sodium isoelectronic sequence.

3.11. The sodium isoelectronic sequence

The available cross section measurements for the sodium isoelectronic sequence are listed in Table 11. FAC has been used to calculate the DI and EA cross sections. The DI cross sections include ionization from the 3s and n = 2 levels. The EA cross sections include excitation into the $2^73l3l'$ and $2^73l4l'$ levels.

For Na I, the low energy range (1–61) is covered by Zapesochnyi & Aleksakhin (1969) and the high energy range (20–1001) is covered by McFarland & Kinney (1965) and Brink (1964) which are in reasonable agreement. The measurements by McFarland & Kinney (1965) show a more natural extrapolation to the high energy limit and so only the cross sections of Zapesochnyi & Aleksakhin (1969) and McFarland & Kinney (1965) have been used for the final fit. The BT-scaled cross sections for Na I data are well fit with a 7 point spline.

Five sets of measurements for Mg II are available. The measurements of Müller et al. (1990) were normalized to those of Crandall et al. (1982) by a multiplicative factor of 1.09. The measurements of Crandall et al. (1982) are about 10% lower than those of Peart et al. (1991b) and Becker et al. (2004). The measurements of Martin et al. (1968) extend over a large energy range and agree with those of Peart et al. (1991b) and Becker et al. (2004) at low energies. There is no clear evidence for significant EA processes although resonant-excitation-double-autoionization signatures are present. Consequently, the measurements of Martin et al. (1968), Peart et al. (1991b), and Becker et al. (2004) and been used and their BT-scaled Mg II data are well fit with a 6-point spline.

For Al III the FAC DI values are about 14% lower than those of Younger (1981b), agree well with the measurements of Thomason & Peart (1998) and are about 30% higher than the measurements of Crandall et al. (1982). The Crandall et al. (1982) measurements have been normalized to those of Thomason & Peart (1998) by a factor of 1.35. The FAC EA cross sections, which are in agreement with those of Griffin et al. (1982a), are too large to explain the observed cross sections. This problem was noted by Griffin et al. (1982a) who suggested that the $2p\to np$ transitions were overestimated. It is not clear why these particular transitions should be problematic. For the results used here, the FAC EA cross sections have been multiplied by a factor of 0.4 to reproduce the measured values rather than excluding the $2p\to np$ transitions.

For Si IV, the FAC DI cross sections are about 11% higher than those of Younger (1981b). The FAC EA cross sections are comparable to those, including the $2p \rightarrow np$ excitations, of

Griffin et al. (1982a), who noted that these were also larger than the measured values. The measurements are well described by the FAC DI cross sections plus the EA cross sections multiplied by a factor of 0.65.

The measured cross sections Rachafi et al. (1991) and Zhang et al. (1992) do not agree very well. At low energies, the error bars are quite large. The FAC and Younger (1981b) DI cross sections agree at the 10% level. EA cross sections have been calculated by Tayal (1994), Reed & Chen (1996), Teng & Xu (1996) and Griffin et al. as reported by Zhang et al. (1992). The FAC DI + EA cross sections are in rough agreement with all of the above calculations except those of Griffin et al., which are approximately twice the value of the other calculations near the peak of the EA contribution at about 400 eV. In this area, their calculations agree with the measurements of Zhang et al. (1992). At energies above 700 eV, the FAC, Tayal (1994), Reed & Chen (1996) and Teng & Xu (1996) cross sections are in good agreement with the measurements of Rachafi et al. (1991) and the cross sections of Griffin et al. appear to approach these measurements as well. For Ar VIII, the FAC cross sections, without any scaling, provide a reasonable estimate of the ionization cross sections.

For Ti XII, the FAC cross sections are in good agreement with the measurements and the calculations of Griffin et al. (1987). For Cr XIV, the FAC cross sections agree with the measurements and with the calculations of Griffin et al. (1987) and Qi et al. (2002) to within 20%.

For Fe XVI, the measurements measurements of Gregory et al. (1987) are about 30% higher than those of Linkemann et al. (1995) near the peak of the EA contribution around 900 eV. The FAC cross sections lie between the two measurements at those energies and appear to agree with the calculations of Griffin et al. (1987) to with 10%. The FAC cross sections for Ni XVIII agree with those of Pindzola et al. (1990) to better than 10%.

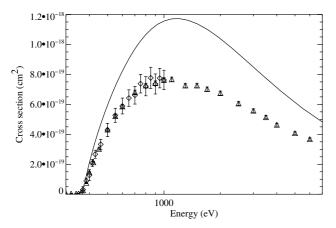
In addition to DI and EA, resonant excitation double Auger (REDA) ionization LaGattuta & Hahn (1981) contributes to ionization of ions in the sodium isoelectronic sequence. The first calculations of REDA cross sections were for Fe xvI by LaGattuta & Hahn (1981). Later calculations by Griffin et al. (1987) suggested that the REDA process was not as important as originally reported by LaGattuta & Hahn (1981), perhaps because of a simplification in their model. For this reason, and because of the difficulty in the calculation of REDA rates, they are not included in the present analysis.

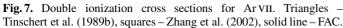
To summarize, the final compilation of ionization cross sections includes the fits to the BT scaled measurements for Na I

Final Experimental Data source Unused data source error error Ion MgI Boivin & Srivastava (1998) 11% 10% Freund et al. (1990) 10% McCallion et al. (1992a) 12% 9% 9% Al II Belic et al. (1987) Montague et al. (1983) Djurić et al. (1993b) 9% 20% Si III Howald et al. (1986) 9% 20% Sv10% 10-30% Cl VI Howald et al. (1986) Howald et al. (1986) Ar VII Chung (1993) 6% 10%

Zhang et al. (2002)

Table 12. Ionization cross section measurements for the magnesium isoelectronic sequence.





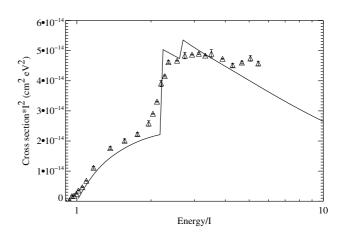


Fig. 8. Ionization cross sections for Ar VII. Measurements – Chung (1993), solid lines – FAC.

and Mg II, FAC cross sections with adjusted EA components for Al III and Si IV and unadjusted FAC cross sections for all other ions.

3.12. The magnesium isoelectronic sequence

The available cross section measurements for the magnesium isoelectronic sequence are listed in Table 12. Direct ionization from the n = 2 shell results in an excited level that can autoionize into a neon-like ion, as previously suggested by Griffin & Pindzola (1988). FAC has been used to calculate DI cross sections from the n = 2 and n = 3 shells. For DI from the n = 2 shell, the branching ratios for radiative decay into a stable sodium-like ion relative to the autoionization to a neon-like ion have also been calculated and used to reduce the DI value. In all cases, autoionization leading to double ionization is the dominant process. The EA cross-sections for excitation into the $2l^73l^{13}$ and $2l^73s^2$ 4l' levels have been calculated with FAC. Theoretical distorted wave calculations of the ionization cross section of Si III (Djurić et al. 1993b), S v, Cl vI, and Ar VII (Pindzola et al. 1986a) and Fe XV (Mitnik et al. 1998) are in good agreement with the FAC values. Figure 7 shows measurements of double ionization in Ar VII and the FAC direct ionization cross sections from the n = 2 level corrected by the branching ratio. It appears that the measured cross section is about 66% of the FAC cross section, while the average calculated branching ratio for autoionization into ArIX is about 0.93.

This leads to the question of which processes should be included in the determination of the ionization cross section for ions in the magnesium isoelectronic sequence. This question will become more apparent when the cross sections for S V, Cl VI,

and Ar VII are discussed below. Laboratory measurements typically refer to ionization into a particular ionization stage whether it is single, double, triple, etc. In order to maintain a consistent analysis, the cross sections and rate coefficients developed here pertain to single ionization processes.

For Mg I, the BT scaled measurements listed are well described by a 6 point spline fit. For Al II, the two sets of measurements agree well up to about 2.5 times threshold but those of Belic et al. (1987) showed the best extension to the high energy limit. The Belic et al. (1987) measurements suggest a small but insignificant contribution from EA processes. BT-scaled values of these measurements were fit with a 6 point spline.

Measurements are also available for the ions Si III, S v, Cl vI, and Ar vII. A major uncertainty in these measurements is the presence of ions in 3s3p³P metastable levels. Their presence is clear in all of these measurements to varying degrees, except for those of Cl vI and the measurements of Chung (1993) for Ar vII. These cross sections, shown in Fig. 8, are relatively well described by the FAC DI + EA cross sections.

To summarize our treatment of the Mg isoelectronic sequence, fits to the BT scaled measurements of MgI and AlII have been used and for the remaining ions the FAC DI and EA cross sections are used.

3.13. The aluminum isoelectronic sequence

The available cross section measurements for the aluminum isoelectronic sequence are listed in Table 13. For all ions PIII through Zn XVIII, the DI cross sections from the n=2 and n=3 shells have been calculated by FAC. As with the magnesium isoelectronic sequence, the DI cross section from the n=2 level

Table 13. Ionization cross section measurements for the aluminum isoelectronic sequence.

			Experimental	Final
Ion	Data source	Unused data source	error	error
Alı	Freund et al. (1990)		10%	10%
Si II	Djurić et al. (1993b)		9%	9%
Cl v	Bannister & Guo (1993)		9%	15%
Ar VI	Gregory & Crandall (1982)	Mueller et al. (1983)	11%	15%
		Zhang et al. (2002)		
Fe xiv	Gregory et al. (1987)		16%	20%
Ni xvi	Cherkani-Hassani et al. (2001)		9%	15%

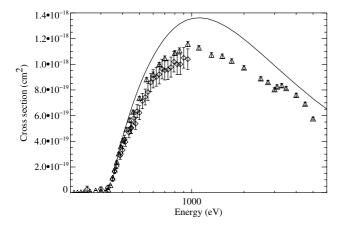


Fig. 9. Double ionization cross sections for Ar VI. Triangles – Zhang et al. (2002), diamonds – Tinschert et al. (1989b), solid line – FAC.

mostly results in double ionization. In Fig. 9 the measured and FAC values for the cross section for double ionization for ar VI are shown. The calculated values are roughly 20% higher than the measured values. For the ions P III through Ar VI FAC EA cross sections through the $2p^63s3pnl$ levels where n=3,4,5 are included. For P III through Zn XVIII the FAC EA cross sections through the $2l^73s^23pnl$ levels with n=3,4 are also included.

For A1I, the BT-scaled cross sections of Freund et al. (1990) are well reproduced by a 9 point spline fit. For Si II, Djurić et al. (1993b) pointed out the strong role of EA through the 2p⁶3s3pn*l* levels. These EA transitions are significantly greater than the DI cross sections at low energies. At higher energies, the EA cross section through the 2p⁵3s²3pn*l* levels is also important Djurić et al. (1993b), and gains in importance for higher values of Z. The FAC cross sections provide a fair reproduction of the Si II cross sections but a 9 point spline fit to the BT-scaled cross sections of Djurić et al. (1993b) is more accurate.

For Cl v the measurements of Bannister & Guo (1993) are well reproduced by the FAC calculations at low energies but at about 6 *I*, the the FAC cross sections for single ionization are about 40% higher than the measured values. For Ar VI, all of the listed measurements are in reasonable agreement at energies above about 3 *I* and are well reproduced by the FAC cross sections. At lower energies, the measurements of Zhang et al. (2002) show evidence of significant metastable ion populations. At energies below 3 *I*, the measurements of Gregory & Crandall (1982) are well reproduced by the FAC cross sections. Figure 10 shows the classically scaled measurements and the FAC calculations for Cl v and Ar VI.

The Fe XIV cross section measurements of Gregory et al. (1987) are about 15% higher than the values calculated by FAC.

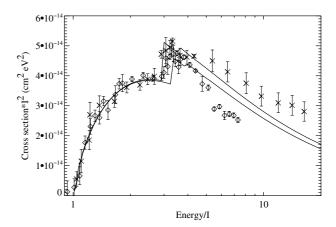


Fig. 10. Classically scaled ionization cross sections for Cl v and Ar VI. Experimental points Bannister & Guo (1993) (diamonds) and Gregory & Crandall (1982) (crosses). FAC calculations for Cl v (bottom line) and Ar VI (top line).

The Ni XVI measurements of Cherkani-Hassani et al. (2001) are well described by the FAC values and also agree well with the calculations of Pindzola et al. (1990). The measurements of double ionization of Ni XVI by Cherkani-Hassani et al. (2001) agree well with the FAC double ionization cross sections from the n = 2 level.

In summary, for the ions AlI and SiII the spline fits to the BT scaled measurements are included in the final compilation of ionization cross sections. For all other ions, the FAC DI and EA cross sections are used.

3.14. The silicon isoelectronic sequence

The available cross section measurements for the silicon isoelectronic sequence are listed in Table 14. DI cross sections from the n=2 (including the single ionization branching ratio) and n=3 levels have been calculated with FAC. EA cross sections have also been calculated with FAC and include excitations from the n=3 level into autoionizing levels of n=3,4,5 for the ions S III, Cl IV and Ar V. For all ions, EA cross sections from the n=2 shell to the n=3,4,5 levels are included.

For Si I, the BT-scaled cross sections of Freund et al. (1990) are well reproduced by an 8 point spline fit. Similarly, for P II, the BT scaled cross sections of Yamada et al. (1989a) are well described by a 6 point spline fit.

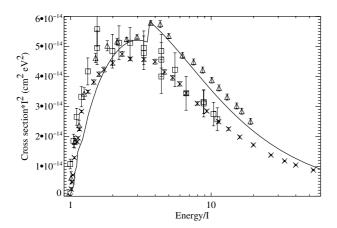
The experimental S III cross sections of Yamada et al. (1988) are well matched by the FAC values near threshold and above 10 times threshold but exceed the measurements at intermediate energies by about 25%. For Ar V the experimental and FAC cross sections are shown in Fig. 11. The measurements of agree with each other to about 40% and there does not appear to

Final Experimental Ion Data source Unused data source error error Si I Freund et al. (1990) 10% 10% Рπ Yamada et al. (1989a) 10% 10% SIII Yamada et al. (1988) 10% 20% Ar V Crandall et al. (1979a) 6% 30% 10% Müller et al. (1980) Zhang et al. (2002) 4% Cr XI 5% 15% Sataka et al. (1989)

Wang et al. (1988)

Cherkani-Hassani et al. (1999)

Table 14. Ionization cross section measurements for the silicon isoelectronic sequence.



Ni xv

Fig. 11. Classically scaled ionization cross sections for Ar V. Experimental points – Crandall et al. (1979a) (triangles), Müller et al. (1980) (squares), Zhang et al. (2002) (x), solid lines – FAC.

be a logical way to decide on a consistent set of measurements. For Cr XI the measurement of Sataka et al. (1989) may indicate the presence of some ions in metastable levels in the beam but provide fair agreement with the FAC calculations, especially in the region where EA transitions are significant. For Ni XV, Griffin & Pindzola (1988) showed that the measured rates of Wang et al. (1988) were commensurate with their calculations of ionization cross sections from the 3p3d excited configuration. There appears to be a similar problem with the measurements of Cherkani-Hassani et al. (1999) which do not agree well with those of Wang et al. (1988). Our FAC cross sections are in good agreement with the cross section of Griffin & Pindzola (1988) from the ground level.

In summary, spline fits to the BT scaled cross sections of Si I and P II are included in the final compilation. There appears to be sufficient agreement between measured and the FAC cross sections for all ions S III through Z XVII that the FAC cross sections have been included as described.

3.15. The phosphorus isoelectronic sequence

The available cross section measurements for the phosphorus isoelectronic sequence are listed in Table 15. For Ar IV and all of the higher members of the phosphorus isoelectronic sequence, DI cross sections from the n=2 (adjusted for double ionization) and n=3 level has been calculated with FAC. For Ar IV it has been necessary to include EA cross sections from the n=3 level to the n=3,4,5 levels. For Ar IV and all of the higher

members of the phosphorus isoelectronic sequence, EA cross sections from the n = 2 shell to n = 4, 5 have been included.

For PI, the BT-scaled cross sections of Freund et al. (1990) are well reproduced by a 7 point spline fit. There are two sets of measurements for SII, those of Yamada et al. (1988) and those of Djurić et al. (1993a), and these are in agreement at about the 15% level. The cross sections of Yamada et al. (1988) are more numerous and extend to higher energy and they are used here. The BT scaled values are well reproduced by a 8 point spline fit. The Cl III are also well reproduced by a 7 point spline fit to the BT scaled measurements.

For ArIV, the measurements of Müller et al. (1980) and Gregory et al. (1983) show a significant cross section at the threshold suggesting that these measurements are compromised by metastables in the beam. The FAC cross sections are in rough agreement($\pm 25\%$) with the measurements at higher energies.

For Fe XII the measurements of Gregory et al. (1987) indicate contributions to the DI cross section from metastable ions in the beam. At higher energies where n=2 EA contributions are important, their measurements are about 20% higher than the FAC cross sections which are in good agreement with the calculations of Pindzola et al. (1986b). For Ni XIV, our calculations are in very good agreement with the measurements of Cherkani-Hassani et al. (2001), see Fig. 12, and the calculations of Pindzola et al. (1990).

In summary, the fits to the BT scaled measurements of PI, SII and ClIII and the FAC cross sections, for all of the other ions, have been included in the final compilation of ions in the phosphorus isoelectronic sequence.

3.16. The sulphur isoelectronic sequence

The available cross section measurements for the sulphur isoelectronic sequence are listed in Table 16. For all ions from Ar III through Zn XV the FAC ionization cross section includes the DI cross section from the n=2 and n=3 levels and the FAC EA cross sections from the n=2 level to the n=4, 5 levels. In addition, for Ar III through Ca V, the FAC EA cross sections from the n=3 to the n=3 level are included.

For S I, the BT-scaled measurements of Freund et al. (1990) are well described by a 9-point spline fit. For Cl II, the measurements of Yamada et al. (1989b) are about 25% higher than those of Djurić et al. (1993b) over most of their energy range, except near threshold where they are in good agreement. The measurements of Djurić et al. (1993b) are used because their classically-scaled values are in better agreement with those of the Ar III. The BT-scaled Cl II measurements of Djurić et al. (1993b) are well described by a 6-point spline fit.

For Ar III, there are 6 sets of experimental measurements reported in the literature. The measurements by

Table 15. Ionization cross section measurements for the phosphorus isoelectronic sequence.

			Experimental	Final
Ion	Data source	Unused data source	error	error
PI	Freund et al. (1990)		10%	10%
SII	Yamada et al. (1988)	Djurić et al. (1993a)	10%	15%
Cl III	Mueller et al. (1985)		5%	6%
Ar IV		Müller et al. (1980)		
		Gregory et al. (1983)		
Fe XII		Gregory et al. (1987)		
Ni xiv	Cherkani-Hassani et al. (2001)		8%	10%

Table 16. Ionization cross section measurements for the sulphur isoelectronic sequence.

			Experimental	Final
Ion	Data source	Unused data source	error	error
Sı	Freund et al. (1990)		10%	10%
Cl II	Djurić et al. (1993b)	Yamada et al. (1989a)	7%	10%
Ar III	Danjo et al. (1984)		10%	20%
	Diserens et al. (1988)		3%	
	Man et al. (1993)		3%	
	Matsumoto et al. (1990)		10%	
	Müller et al. (1980)		10%	
	Mueller et al. (1985)		9%	
Ti VII		Hartenfeller et al. (1998)		
CrIX		Sataka et al. (1989)		
Fe XI		Stenke et al. (1999)		
Ni XIII		Cherkani-Hassani et al. (1999)		
		Wang et al. (1988)		

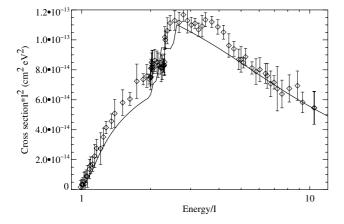


Fig. 12. Classically scaled values of Ni XIV cross sections. Points with error bars are the measurements of Cherkani-Hassani et al. (2001). Solid line is the FAC calculation.

Diserens et al. (1988) and Man et al. (1993) were made with the same apparatus and are nearly identical. The measurements by Danjo et al. (1984) and Matsumoto et al. (1990) are also nearly identical and appear to be by the same research group. The various measurements agree at the 10–25% level. The FAC cross sections agree with these measurements at the 20% level.

For Ti VII, the measurements of Hartenfeller et al. (1998) were made on a beam containing both metastable and ground state ions. Their calculations are in reasonable agreement with the FAC calculations, and their measurements at high energies are also in reasonable agreement with the FAC calculations. The Sataka et al. (1989) measurements for Cr IX also show the presence of metastables in the beam and are generally about 25% higher than the FAC calculations. The Fe XI measurements also

show strong indications of metastables and are about 35% higher than the FAC cross sections at high energies.

The experimental measurements for Ni XIII by Cherkani-Hassani et al. (1999) and Wang et al. (1988) are in good agreement but pertain to ionization from an excited metastable state, based on a comparison with the calculations by Griffin & Pindzola (1988). The FAC cross sections are in good agreement with those of Griffin & Pindzola (1988) from the ground level.

In summary, the ionization rate coefficients are derived from the fits to the measured cross sections for SI and ClII. For the other members of the sulphur isoelectronic sequence, the FAC ionization cross sections as described above are included in the final compilation.

3.17. The chlorine isoelectronic sequence

The available cross section measurements for the chlorine isoelectronic sequence are listed in Table 17. For the ions K III through Zn XIV, ionization cross sections have been calculated with FAC. These include the DI cross section from the n=2(reduced by for double ionization) and n=3 shells and the EA cross sections from the n=2 level to the n=4,5 levels and from the n=3 to the n=6,7,8 levels.

For Cl I, the BT-scaled measurements of Hayes et al. (1987) are well described by a 9-point spline fit. For Ar II, there is good agreement among all of the measurements listed in Table 16 except for those of Müller et al. (1985a) which are significantly lower than the rest. The BT scaled cross sections of Ar II, excluding Müller et al. (1985a), are well fit with a 9-point spline.

For Ti VI, Hartenfeller et al. (1998) compared their measurements with those of Chantrenne et al. (1990) and distorted wave calculations. They find that the two sets of measurements are in good agreement but that they both lie between the ionization

Table 17. Ionization cross section measurements for the chlorine isoelectronic sequence.

			Experimental	Final
Ion	Data source	Unused data source	error	error
Cli	Hayes et al. (1987)		14%	14%
Ar II	Gao et al. (1997)	Müller et al. (1980)	10%	5%
	Man et al. (1987b)		3%	
	Müller et al. (1985a)		3%	
	Yamada et al. (1989b)		10%	
Ti VI		Chantrenne et al. (1990)		
		Hartenfeller et al. (1998)		
Cr VIII		Sataka et al. (1989)		
Mn IX		Rejoub & Phaneuf (2000)		
Fe x		Gregory et al. (1987)		
		Stenke et al. (1995b)		
Ni XII	Cherkani-Hassani et al. (1999)	. ,	6%	10%

Table 18. Ionization cross section measurements for the argon isoelectronic sequence.

			Experimental	Final
Ion	Data source	Unused data source	error	error
Arı	Ma et al. (1991)		15%	5%
	McCallion et al. (1992b)		6%	
	Nagy et al. (1980)		6%	
	Stephan et al. (1980)		8%	
	Straub et al. (1995)		3%	
	Wetzel et al. (1987)		15%	
Кп	Hirayama et al. (1986)		13%	6%
	Hooper et al. (1966)		15%	
	Peart & Dolder (1968)		6%	
Ti V		Hartenfeller et al. (1998)		
Cr VII		Sataka et al. (1989)		
Mn VIII		Rejoub & Phaneuf (2000)		
Ni XI		Cherkani-Hassani et al. (1999)		

rate they calculate from the ground state and from the $3p^43d$ excited state and concluded that there were significant levels of metastables in both beams. The FAC cross section sections are in generally good (15%) agreement with the measurements at high energies.

Ionization cross sections of Cr VIII have been measured by Sataka et al. (1989). They found a significant cross section at energies below the ground level threshold and showed that these enhanced values were consistent with the direct ionization rate predicted by the Lotz Lotz (1967b) formula for ionization from a metastable 3p⁴3d level. The FAC cross sections generally lie about 15% below the measurements of Sataka et al. (1989).

Cross sections for Mn IX have been measured by Rejoub & Phaneuf (2000). However, when the classically scaled measurements for ions in the chlorine isoelectronic sequence (Ti VI through Ni XII) are compared, the Mn IX values are the highest, for no apparent reason. Consequently the Mn IX measurements are not included.

Gregory et al. (1986) and Stenke et al. (1995b) have measured the ionization cross section of Fe x. Stenke et al. (1995b) shows there is good agreement between the two sets of measurements and that both are consistent with ionization from the 3p⁴3d metastable level. The FAC cross sections lie about 25% below the measurements above about 900 eV where the EA contributions are apparent and about 10% above the calculations by Pindzola et al. (1986b).

Cross sections for Ni XII have been measured by Cherkani-Hassani et al. (2001) and are in good agreement with the FAC calculations and those of Pindzola et al. (1990).

In summary, the fits to the BT scaled cross sections for Cl I and Ar II and the FAC cross sections, for all other ions in the Cl isoelectronic sequence, are included in the final compilation.

3.18. The argon isoelectronic sequence

The available cross section measurements for the chlorine isoelectronic sequence are listed in Table 18. Ionization cross sections have been calculated with FAC. These calculations included the DI cross section from the n=3 shell and the EA cross sections from the n=2 level to the n=4,5 levels and from the n=3 to the n=4,5 levels. Not all levels contribute to the EA transitions. For example, for V VI and above, most of the n=4 levels are below the ionization limit.

For Ar I and K II, the measurements listed in Table 18 are well fit by a 6-point spline fit to the BT scaled values.

Measurements of the ions Ti V, Cr VII and Ni XI show strong evidence of significant levels of metastables in the beams. The measurements for Mn VIII show no evidence of a significant cross section below the ground level threshold. However, their classically-scaled values are higher than the other members of the sequence and also significantly higher than the FAC calculated values. For Ni XI, the FAC cross sections are in good agreement with those of Pindzola et al. (1990) from the ground level and in good agreement with the DI cross sections of Younger (1982b)

In summary, the fits to the BT scaled cross sections for ArI and KII are used for the final compilation of ionization cross sections. For the higher Z members of the argon isoelectronic sequence, there are no reliable ground state ionization

			Experimental	Final
Ion	Data source	Unused data source	error	error
Κı	Brink (1964)		20%	15%
	Korchevoi & Przonski (1967)		_	
	McFarland & Kinney (1965)		_	
	Zapesochnyi & Aleksakhin (1969)		15%	
CaII	Peart & Dolder (1975)		10%	25%
	Peart et al. (1989)		8%	
Sc III	Pindzola et al. (1994)		8%	8%
Ti IV	Falk et al. (1983)	van Zoest et al. (2004)	9%	9%
Mn VII		Rejoub & Phaneuf (2000)		

Table 19. Ionization cross section measurements for the potassium isoelectronic sequence.

measurements. Consequently, the FAC cross section, based on their agreement with the calculations of Pindzola et al. (1990) for Ni XI, are included for all other ions in the argon isoelectronic sequence.

3.19. The potassium isoelectronic sequence

The available cross section measurements for the potassium isoelectronic sequence are listed in Table 19. FAC has been used to calculate the DI cross section from the 3p and 3d shells. The EA cross sections were calculated including excitation from the $3p^63d$ to the $3p^53d$ n*l* levels with n = 4, 5, 6.

For K I, the measurements are well fit by a 6-point spline fit to the BT-scaled values.

For CaII, the ground level is 3p⁶4s. Calculations by Burke et al. (1983), Griffin et al. (1984), Pindzola et al. (1987) and Badnell et al. (1991) have attempted to reproduce the ionization cross section of Ca II by including direct ionization and excitation-autoionization through the 3p⁵3d4s and 3p⁵4s² levels. Badnell et al. (1991) has been the most successful in modeling the energy range between 25 and 45 eV, where the EA contributions are important, by means of an R-matrix calculation. FAC has been used to calculate the direct ionization cross sections from the 4s and inner-shell 3p level and the EA cross sections through the the $3p^53d4s$ and $3p^54s^2$ levels. All of the calculations just mentioned required an adjustment to the DI cross sections below 25 eV to reproduce the measured values and the current FAC DI cross section from the 4s level has been multiplied by a factor of 0.5. At energies above about 100 eV there appears to be a significant contribution to the cross section from direct ionization from the n = 3 level. With the modified DI cross sections plus the EA cross sections, a reasonable reproduction of the measured Ca II ionization cross sections are found although the Badnell et al. (1991) calculations provide a better fit in the region between 25 and 45 eV.

For Sc III the best reproduction of the measured cross sections has been with R-matrix calculations (Pindzola et al. 1994). For Sc III, the FAC cross sections are in good agreement with the measurements about about 2*I* but not below that energy. The best reproduction of the measured cross sections are obtained with a 6-point spline fit to the BT scaled cross sections.

For Ti IV the measurements of van Zoest et al. (2004) and Falk et al. (1983) are in reasonable agreement at high energies but differ by as much as 40% near the peak. Perhaps the most accurate calculations of the Ti IV cross section are the R-matrix results of Burke et al. (1984) and Gorczyca et al. (1994). These appear to agree somewhat better with the measurements of Falk et al. (1983) than those of van Zoest et al. (2004). The FAC distorted wave calculations for Ti IV significantly overestimate the measurements at energies somewhat above threshold but are

in good agreement at high energies. Consequently, 7-point spline fits to the BT scaled cross sections of Falk et al. (1983) are used for Ti IV.

The measurements for Mn VII by Rejoub & Phaneuf (2000) are about 80% higher than the FAC calculations. However, these measurements, when scaled classically, appear to be out of line with other measurements and calculations. In the case of Ni x, the FAC cross sections are about 30% lower than those of Pindzola et al. (1990).

To summarize, the fits to the BT scaled cross sections have been used for K I, Sc III and Ti IV. For Ca II and the ions V V through Zn XII, the FAC cross sections have been used as described for the final compilation of ionization cross sections.

3.20. The calcium isoelectronic sequence

The available cross section measurements for the calcium isoelectronic sequence are listed in Table 20. For members of the calcium isoelectronic sequence, FAC has been used to calculate DI and EA cross sections. The DI cross sections include ionization from the 3p and 3d shells. For the EA cross sections, autoionizing levels include the n=3,4,5,6 and 7 shells (Sc II through Mn VI), n=4,5,6 and 7 shells for all other ions.

For Ca I, the BT scaled values of the available measurements are well fit by a 9-point spline fit.

The Sc II measurements of Jacobi et al. (2004) are well described by their R-matrix calculations. In order for the FAC calculations to reproduce the measurements, it is necessary to multiply the FAC EA contribution by a factor of 0.4. For Ti III, of the three sets of measurements those of Mueller et al. (1985) and Diserens et al. (1988) are in the best agreements. Those of Hartenfeller et al. (1998) indicate the presence of metastable ions in the beam and have not been included in the present analysis. The measurements are best reproduced if the FAC EA contributions are reduced by a factor of 0.4. For Mn VI the measurements are in rough agreement with the FAC values. However, it should be noted that the measurements of Rejoub & Phaneuf (2000) have often been problematical, as mentioned before. For Fe VII, the FAC cross section are in good agreement with the measured values and with the calculations of Pindzola et al. (1986b). The FAC cross sections for Ni IX are in fair agreement with the measurements but agree well (15%) with the calculations of Pindzola et al. (1990).

For Ca I a spline fit to the BT scaled measured cross sections are used for the final compilation of ionization cross sections. For all other ions, the FAC calculations have been used. For Sc II and Ti III only, the FAC EA contributions have been reduced by a factor of 0.4.

			Experimental	Final
Ion	Data source	Unused data source	error	error
Caı	Okuno (1971)		8%	8%
	Rakhovskii & Stepanov (1969)		24%	
	Vainshtein et al. (1972)		16%	
Sc II	Jacobi et al. (2004)		15%	15%
Ti III	Mueller et al. (1985)	Hartenfeller et al. (1998)	9%	25%
	Diserens et al. (1988)		3%	
Mn vi	Rejoub & Phaneuf (2000)		25%	50%
Fe VII	Gregory et al. (1986)		5&	12%
	Stenke et al. (1999)		8%	
Ni IX	Wang et al. (1988)		6%	25%

Table 20. Ionization cross section measurements for the calcium isoelectronic sequence.

Table 21. Ionization cross section measurements for the scandium iso-electronic sequence.

<u></u>		Experimental	Final
Ion	Data source	error	error
ScI	Tawara (2002)		
Ti II	Diserens et al. (1988)	3%	40%
	Hartenfeller et al. (1998)	8%	
Fe VI	Gregory et al. (1986)	7%	10%
	Stenke et al. (1999)	8%	
Ni VIII	Wang et al. (1988)	6%	15%

3.21. The scandium isoelectronic sequence

The available cross section measurements for the scandium isoelectronic sequence are listed in Table 21. For Ti II, which has a $3d^24s$ ground configuration, FAC has been used to calculate the DI cross sections from the 4s and 3d shells and to calculate the EA cross sections for excitation to the $3p^53d^34s$ level. For the remaining members of the scandium isoelectronic sequence, which have a $3d^3$ ground configuration, FAC has been used to calculate the DI cross sections from the 3p and 3d levels and the EA cross sections from the 3s and 3p levels to the n = 3, 4, 5, 6, and 7 levels. For Co VII through Zn X the n = 3 levels are bound and do not contribute to EA.

For Sc I, the BT scaled measurements are well fit by by a 9 point spline, however, the experimental errors are unknown. The FAC cross sections for Ti II are in reasonably good agreement with the measurements, especially at the highest energies. The measurements for Fe VI are fit to 10% or better by the FAC cross sections which also appear to be in very good agreement with those of Pindzola et al. (1986b). The FAC cross sections for Ni VIII also agree with the measurements and the calculations of Pindzola et al. (1990) to better that 15%.

Consequently, for ions in the scandium isoelectronic sequence, the spline fit to the BT scaled measurements of ScI are used for the final compilation and the FAC DI and EA cross sections have been used as discussed above, for all other ions.

3.22. The titanium isoelectronic sequence

The available cross section measurements for the titanium isoelectronic sequence are listed in Table 22. FAC has been used to calculate the DI cross sections from the 3p and 3d shells and the EA cross sections, including excitation to the n = 3, 4, 5, and 6 shells.

For Ti I, the BT scaled measurements of Tawara (2002) are well fit by by a 7 point spline. However, Tawara (2002) does not provide error estimates.

Table 22. Ionization cross section measurements for the titanium iso-electronic sequence.

Ion	Data source	Experimental error	Final error
TiI	Tawara (2002)	Ciroi	CITOI
Fe v	Stenke et al. (1999)	8%	8%
Ni VII	Wang et al. (1988)	6%	10%

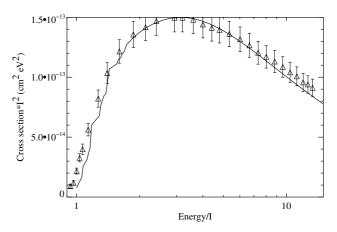


Fig. 13. Fe v ionization cross sections. Points with error bars are the measurements of Stenke et al. (1999). Solid line is the FAC cross section

For Fe V, Stenke et al. (1999) were able to reproduce their measurements with their own distorted wave calculations. In the case of Ni VII, the measurements of Wang et al. (1988) are relatively well reproduced by the calculations of Griffin & Pindzola (1988). The FAC cross sections for Fe V are in good agreement with the measurements for Fe V and for Ni VII. The Fe V cross sections are shown in Fig. 13.

For the final collection of ionization cross sections, the FAC calculations are used with the except of spline fits to the BT scaled measurements of Ti I.

3.23. The vanadium isoelectronic sequence

The available cross section measurements for the vanadium isoelectronic sequence are listed in Table 23. FAC has been used to calculate the DI cross sections from the n=3 level and the EA cross sections, including excitation from the 3s and 3p levels to the n=3 shell and from the 3p level to the n=4 shell.

For V I and Cr II, the BT scaled measurements are well fit by 6 point and 9 point splines, respectively.

Table 23. Ionization cross section measurements for the vanadium iso-electronic sequence.

			Experimental	Final
Ion	Data source	Unused data source	error	error
Vı	Tawara (2002)			
CrII	Man et al. (1987a)		2.5%	5%
Fe IV		Stenke et al. (1999)		
Ni VI	Wang et al. (1988)		6%	15%
	Stenke et al. (1995a)		6%	

For Fe IV, Stenke et al. (1999) notes that there seem to be a significant amount of metastable (3p⁴4s) impurity ions in their beam. The FAC cross sections are in good agreement with the CADW cross sections reported by Griffin et al. (1982b) and Stenke et al. (1999). For Ni VI the measurements of Wang et al. (1988) and Stenke et al. (1995a) are well described by the FAC calculations which are also in agreement with the calculations of Griffin & Pindzola (1988).

For the final compilation of ionization cross sections, the fits to the BT scaled cross sections of VI and CrII are used and the FAC cross sections are used for all other ions.

3.24. The chromium isoelectronic sequence

The available cross section measurements for the chromium isoelectronic sequence are listed in Table 24. The ground configuration of Mn II is $3s^23p^63d^54s$ and for more highly ionized members of the chromium isoelectronic sequence, it is $3s^23p^63d^6$. For all ionized species, FAC has been used to calculate the DI and EA cross sections. For Mn II, DI cross sections from the 3d and 4s levels are included and EA cross sections for 3p to 3d and n = 4 levels are included. For the other ions, DI from the 3p and 3d levels are included and EA excitations from the 3s and 3p levels to the 3d level and from the 3p levels to the n = 4 shell.

For Cr I there do not appear to be any available measurements of the ionization cross section. Tawara (2002) has apparently combined the theoretical values of Reid et al. (1992) at low energies and those of McGuire (1977) at high energies. The BT scaled values of Tawara (2002) are well fit by a 6 point spline.

For Fe III, the measurements of Mueller et al. (1985) and Stenke et al. (1999) were not used since they showed a significant cross section at the threshold indicating the presence of metastables in the beam. The FAC cross sections are somewhat larger than the CADW cross sections reported by Stenke et al. (1999), probably because more transitions have been included in the FAC calculations

The measurements for Ni V of Bannister & Guo (1993) and Stenke et al. (1995a) are well-reproduced by the FAC calculations and are in very good agreement with the calculations of Pindzola et al. (1990).

In the final tabulation, FAC cross sections for all the members of the chromium isoelectronic sequence, aside from the spline fits to the BT scaled measurements of Cr I, have been included in the final compilation.

3.25. The manganese isoelectronic sequence

The available cross section measurements for the manganese isoelectronic sequence are listed in Table 25. The ground configuration of Fe II is $3s^23p^63d^64s$ while for more highly ionized members of the chromium isoelectronic sequence, it is $3s^23p^63d^7$. For Co III and above, FAC has been used to calculate the DI cross sections from the 3p and 3d levels.

For Mn I the BT scaled measurements are well fit by 6-point spline. In the case of Fe II and Ni IV, the two sets of measurements by Stenke and colleagues show a significant cross section at threshold, indicated the presence of metastable ions. Consequently, 9 and 6 point spline fits to the BT scaled cross sections of Montague et al. (1984a) and Gregory & Howald (1986), respectively, have been used.

The FAC DI cross sections for Ni IV overestimate the measurements by about 25% near the peak. The same situation applies to the cross sections of Pindzola et al. (1990). Since there is little structure in the cross section of Ni IV a spline fit to the scaled BT cross sections are a practical approach.

To summarize, the final compilation of ionization cross sections use the BT scaled fits for Mn I, Fe II and Ni IV. The fits for Ni IV together with the appropriate ionization potential have been applied to the remaining members of the manganese isoelectronic sequence.

3.26. The iron isoelectronic sequence

The available cross section measurements for the iron isoelectronic sequence are listed in Table 26. FAC has been used to calculate the DI cross sections from the 3d level.

For Fe I the BT scaled measurements are well fit by 6 point splines. It should be noted that the ionization cross sections of Tawara (2002) is an unreferenced compilation. In this case, the Fe I values appear to be a correction of Freund et al. (1990) which show a significant cross section at the ionization threshold, indicating the presence of metastable ions in their beam.

The measurements of Ni III by Stenke et al. (1995a) show a significant cross section at the threshold, indicating ions in metastable levels in the beam. However, at about 3*I*, their measurements agree with the CADW calculations of Pindzola et al. (1990). The FAC DI cross sections are 20–30% higher than the values of Pindzola et al. (1990).

For Cu IV, the measurements are not well reproduced by the FAC DI cross sections and a 6 point spline fit to the BT scaled measurements is used.

The fits to the BT scaled cross sections of CuIV have been used together with the appropriate ionization potential for all ions in the iron isoelectronic sequence aside from Fe I.

3.27. The cobalt isoelectronic sequence

The available cross section measurements for the cobalt isoelectronic sequence are listed in Table 27. For Co I, Ni II and Cu III, the BT scaled measurements are well fit by 6 point, 7 point and 6 point splines, respectively. For the remaining member of the cobalt isoelectronic sequence, the BT scaled fit for Cu III has been used together with the appropriate ionization potential.

3.28. The nickel isoelectronic sequence

For Ni I, the BT scaled measurements of Tawara (2002) are well fit by a 6 point spline. For Cu II and Zn III, there are no known measurements available and the FAC DI cross sections from the 3d shell have been used.

Table 24. Ionization cross section measurements for the chromium isoelectronic sequence.

-			Experimental	Final
Ion	Data source	Unused data source	error	error
CrI	Tawara (2002)			
Fe III		Mueller et al. (1985)		
		Stenke et al. (1999)		
Ni v	Bannister & Guo (1993)		7%	15%
	Stenke et al. (1995a)		8%	

Table 25. Ionization cross section measurements for the manganese isoelectronic sequence.

			Experimental	Final
Ion	Data source	Unused data source	error	error
Mn I	Tawara (2002)			
Fe II	Montague et al. (1984a)	Stenke et al. (1999)	2.4%	2.4%
Ni IV	Gregory & Howald (1986)	Stenke et al. (1995a)	5%	5%

Table 26. Ionization cross section measurements for the iron isoelectronic sequence.

<u> </u>			Experimental	Final
Ion	Data source	Unused data source	error	error
Fe I	Tawara (2002)			
Ni III		Stenke et al. (1995a)		
CuIV	Gregory & Howald (1986)		4%	8%

Table 27. Ionization cross section measurements for the cobalt isoelectronic sequence.

		Experimental	Final
Ion	Data source	error	error
CoI	Tawara (2002)		
Ni II	Montague et al. (1984b)	3%	5%
Cu III	Gregory et al. (1986)	4%	4%

3.29. The copper isoelectronic sequence

The available cross section measurements for the copper isoelectronic sequence are listed in Table 28. For Cu I and Zn II, the BT scaled measurements are well fit by 6 point splines. The measurements of Freund et al. (1990) have not been used because of an apparent presence of metastable ions in their beam.

3.30. The zinc isoelectronic sequence

For Zn I the BT scaled measurements of Tawara (2002) are well fit by a 6 point spline.

3.31. Error assessment

Figure 14 shows a histogram of the final errors given in Tables 1 through 28. The median value of the final errors is 10% and the average value is 13%. Generally, the final errors are smallest for the neutral and singly ionized species where the measurement are made with high accuracy. The cross sections are usually featureless and can be well fit. For highly ionized species, where the distorted wave FAC calculations should be the most accurate, there are typically few measurements and the accuracy of these measurements is not particularly high and so the final error is then also high.

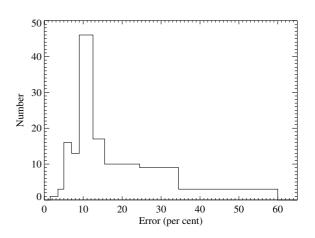


Fig. 14. Histogram of final errors.

4. Ionization rate coefficients

The ionization rate coefficients R(T) for all ions of all elements hydrogen through zinc have been calculated by a 12 point Gauss-Laguerre integration over the ionization cross sections. The DI and EA rates were calculated separately and summed. A Burgess-Tully type scaling has been applied to these rates with a scaled temperature x,

$$x = 1 - \frac{\log f}{\log(t+f)} \tag{4}$$

where t = kT/I and kT is in the same units as the ionization potential I. A value of f = 2.0 has been used for all fits presented here. The scaled rate coefficient ρ is given by

$$\rho = t^{\frac{1}{2}} I^{\frac{3}{2}} R(T) / E_1(1/t) \tag{5}$$

where R(T) is the DI + EA ionization rate coefficient at the temperature T and E_1 is the first exponential integral.

Table 28. Ionization cross section measurements for the copper isoelectronic sequence.

			Experimental	Final
Ion	Data source	Unused data source	error	error
Cu I	Bolorizadeh et al. (1984)	Freund et al. (1990)	13%	13%
Zn II	Peart et al. (1991a)		10%	10%
	Rogers et al. (1982)		10%	

Table 29. Spline fits, multiplied by a factor of 10^6 , to the scaled ionization rate coefficients. Table 29 in its entirety is only available in electronic form at the CDS.

Z	Ion	NS	I (eV)	T_{\min}								
Spline nodes												
Spline values												
2	1	20	24.587	1.000e+04								
0.0244	0.0500	0.1000	0.1500	0.2000	0.2500	0.3000	0.3500	0.4000	0.4500			
	0.5000	0.5500	0.6000	0.6500	0.7000	0.7500	0.8000	0.8500	0.9000	0.9151		
1.1152	1.2670	1.5608	1.8526	2.1431	2.4328	2.7222	3.0121	3.3048	3.6029			
	3.9066	4.2150	4.5277	4.8442	5.1551	5.4444	5.6808	5.7493	5.3837	5.1643		
2	2	20	54.418	2.239e+04								
0.0247	0.0500	0.1000	0.1500	0.2000	0.2500	0.3000	0.3500	0.4000	0.4500			
	0.5000	0.5500	0.6000	0.6500	0.7000	0.7500	0.8000	0.8500	0.9000	0.9059		
1.6093	1.6839	1.8089	1.9142	2.0097	2.1001	2.1891	2.2779	2.3649	2.4510			
	2.5330	2.6077	2.6758	2.7302	2.7551	2.7353	2.6698	2.5085	2.1720	2.1219		

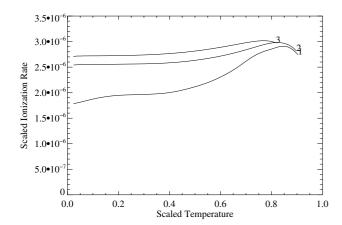


Fig. 15. BT scaled ionization rates for C IV (1), N V (2) and Fe XXIV (3).

Figure 15 shows BT scaled ionization rates for ions in the lithium isoelectronic sequence. It can be seen that the scaled rates are rapidly approaching the high Z limit.

Table 29 presents the spline fits to the BT scaled rate coefficients. The first line gives the nuclear charge Z, the ionization stage (following spectroscopic notation), the ionization potential I in eV and the minimum temperature for which the fits are applicable. The fits are accurate up to a temperature of 10^9 K in all cases. The second entry, broken across two lines, are the values of x where the spline has been fit. The third entry, also broken across two lines, are the values of the spline fit multiplied by 10^6 . The fact that the values of the spline fits are nearly constant indicates the usefulness of the scaling procedure. As the complete Table 29 is very large it is only available electronically and only the value of He I and He II are shown here.

To recover the rate coefficients from the scaled values, the inverse formulae are used:

$$T = \left(\frac{I}{k}\right) \left(\exp\left[\frac{\log f}{1-x}\right] - f\right) \tag{6}$$

$$R = t^{-1/2} I^{-3/2} E_1(1/t) \rho. (7)$$

As an example of how to apply Table 29, for He II (Z=2, stage = 2), a spline node value of x=0.10 corresponds to a temperature of 1.01×10^5 K, using an ionization potential I=54.42 eV and $k=8.617\times 10^{-5}$ eV K⁻¹ in Eq. (6). The reduced temperature t=(kT/I)=0.16. The spline value corresponding to this temperature is 1.8095×10^{-6} . The factor of 10^{-6} recovers the scaling used to create Table 29. Using Eq. (7), the ionization rate coefficient $R=3.06\times 10^{-12}$ cm³ s⁻¹. In order to determine the ionization rate coefficient at other temperatures, it is best to scale the temperature using Eq. (4) and then interpolate between the slowly varying scaled rate coefficients ρ .

In order to assess the differences between these new ionization rates and those of Arnaud & Rothenflug (1985), Arnaud & Raymond (1992), ionization equilibria been calculated for the elements C, N, O, F, Ne, Mg, Si, Ca, Fe, and Ni using the recombination rates of Mazzotta et al. (1998). These include the radiative recombination rates of Shull & Steenberg (1982) and a compilation of dielectronic recombination rates from the literature. A comparison between these two sets of ionization equilibrium shows typical differences ranging from negligible to 20-30%. The greatest differences were found for the ions Ni V through Ni XI that can be traced to the fact that Arnaud & Rothenflug (1985) did not include EA rates for ions with more than 18 electrons (beyond the Ar isoelectronic sequence). For the case of iron, this was corrected by Arnaud & Raymond (1992). For some of these nickel ions, differences can approach 60%. Similar problems are likely to be found for the elements cobalt, copper and zinc but these do not have very high astrophysical abundances. Another significant difference is for the ions CV and CVI and is attributable to an apparent error in ionization equilibrium tabulation by Mazzotta et al. (1998) for these ions and not their stated ionization rate. This error is apparently widely recognized.

In Fig. 16, the ionization rate coefficients for the ions Fe IX, Fe XI,Fe XIII, and Fe XV developed here are plotted together with the rates from Arnaud & Raymond (1992). The differences can be as large as about 30%. Similarly, the present rate coefficients for the ions Ni V, Ni VII, and Ni IX are shown in Fig. 17 together

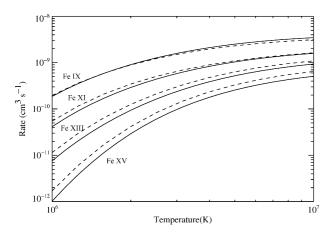


Fig. 16. Ionization rate coefficients for selected iron ions. Solid line present results, dashed line - Arnaud & Raymond (1992).

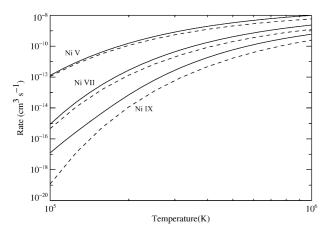


Fig. 17. Ionization rate coefficients for selected nickel ions. Solid line present results, dashed line - Arnaud & Rothenflug (1985).

with those of Arnaud & Rothenflug (1985). The differences can be quite substantial and would affect the calculated ionization equilibria.

5. Discussion

Through the use of a combination of ionization scaling laws and atomic calculations with FAC and other codes, it has been possible to reproduce measured electron ionization cross section to a fair degree of accuracy, generally on the order of about 20% or better. In all cases, the high-energy Bethe limit for the ionization cross sections has been incorporated.

Since the earlier investigations of electron ionization rates of Arnaud & Rothenflug (1985), Arnaud & Raymond (1992), there have been a considerable number of reported measurements of ionization cross sections. Future improvements in our knowledge of ionization cross sections will likely come about through improvements in our ability to calculate these cross sections and through new measurements. Further, the current set of cross sections and rate coefficients refer to ionization from the ground level. The inclusion of ionization from metastable levels will be useful in exploring the ionization state of plasmas, such as the solar corona, where metastable levels have significant populations, e.g. Nussbaumer & Storey (1975).

6. Summary

A complete, new set of ground level electron collision ionization rate coefficients has been developed for all atoms and ions of the elements from hydrogen through zinc. These are based on an analysis of measurements of ionization cross sections and theoretical calculations with FAC and other codes. The use of scaling laws for ionization has facilitated this analysis. Differences between these rates and those of Arnaud & Rothenflug (1985) and Arnaud & Raymond (1992) are not particularly large except for some ions of nickel. Fits to the scaled rate coefficients are presented here as an electronically available table. In the near future, the cross sections and rate coefficients will be inserted into the CHIANTI atomic database where they will be freely available.

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